Chapter 3

Crosstalk

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Outline

- Mutual Inductance and Mutual Capacitance
- Inductance and Capacitance Matrix
- Field Simulators
- Crosstalk-Induced Noise
- Simulating Crosstalk Using Equivalent Circuit Models
- Crosstalk-Induced Flight Time and Signal Integrity Variations
- Crosstalk Trends
- Termination of Odd- and Even-Mode Transmission Line Pairs
- Minimization of Crosstalk
- Additional Examples

Introduction

- Influences of Crosstalk
 - Disadvantages
 - First, crosstalk will change the performance of impedance and propagation velocity, which will adversely affect system-level timings and the integrity of the signal.
 - Additionally, crosstalk will induce noise onto other lines, which may further degrade the signal integrity and reduce noise margins.
 - Influence Factors
 - Data patterns, line-to-line spacing, and switching rates.

Mutual Inductance and Mutual Capacitance

- Mutual Inductance
 - Definition
 - The coupling of current via the magnetic field is represented in the circuit model by a mutual inductance L_m .
 - Mutual Inductance-Induced Noise
 - The mutual inductance L_m will inject a voltage noise onto the victim proportional to the rate of change of the current on the driver line.
 - The magnitude of this noise is calculated as

$$V_{\text{noise},L_m} = L_m \frac{dI_{\text{driver}}}{dt}$$

Mutual Inductance and Mutual Capacitance

- Mutual Capacitance
 - Definition
 - The coupling due to the electric field is represented in the circuit model by a mutual capacitor C_m .
 - Mutual Capacitance-Induced Noise
 - Mutual capacitance C_m will inject a current onto the victim line proportional to the rate in change of voltage on the driven line.
 - The magnitude of this noise is calculated as

$$I_{\text{noise},C_m} = C_m \frac{dV_{\text{driver}}}{dt}$$

Inductance and Capacitance Matrix

- Introduction
 - The inductance and capacitance matrices are known collectively as the *transmission line matrices*.
- Inductance Matrix
 - Definition
 - For an *N*-conductor system, the inductance matrix could be expressed as

Inductance matrix =
$$\begin{bmatrix} L_{11} & L_{12} & \cdots & L_{1N} \\ L_{21} & L_{22} & & & \\ \vdots & & \ddots & & \\ L_{N1} & & & L_{NN} \end{bmatrix}$$

• where L_{NN} is the self-inductance of line N and L_{MN} is the mutual inductance between lines M and N.

Inductance and Capacitance Matrix

- Capacitance Matrix
 - Definition
 - For an *N*-conductor system, the capacitance matrix could be expressed as

Capacitance matrix =
$$\begin{bmatrix} C_{11} & C_{12} & \cdots & C_{1N} \\ C_{21} & C_{22} & & & \\ \vdots & & \ddots & & \\ C_{N1} & & & C_{NN} \end{bmatrix}$$

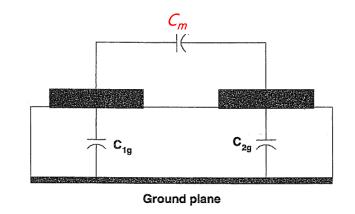
• where C_{NN} is the total capacitance seen by line N, which consists of conductor N's capacitance to ground plus all the mutual capacitance to other lines and C_{NM} = mutual capacitance between conductors N and M.

Inductance and Capacitance Matrix

- Capacitance Matrix
 - Example 3.1 Two-Conductor TX Line Matrices
 - The capacitance matrix is

capacitance matrix =
$$\begin{bmatrix} C_{11} & C_{12} \\ C_{21} & C_{22} \end{bmatrix}$$

$$\begin{bmatrix} Q_1 \\ Q_2 \end{bmatrix} = \begin{bmatrix} C_{11} & C_{12} \\ C_{21} & C_{22} \end{bmatrix} \begin{bmatrix} V_1 \\ V_2 \end{bmatrix}$$



- where $C_{11} = C_{1g} + C_m$ $C_{12} = C_{21} = -C_m$
- The inductance matrix is

inductance matrix =
$$\begin{bmatrix} L_{11} & L_{12} \\ L_{21} & L_{22} \end{bmatrix}$$

 C_{11} is obtained by setting V_2 =0, i.e. V_2 grounded

Field Simulators

Categories

- Electrostatic (2D)
 - Advantage:
 - very easy to use and typically take a very short amount of time to complete the calculations.
 - Disadvantages:
 - simulate only relatively simple geometries.
 - They are based on static calculations of the electric field,
 and they usually do not calculate frequency-dependent
 effects such as internal inductance or skin effect resistance.
 - However, there are alternative methods of calculating effects such as frequency-dependent resistance and inductance.

Field Simulators

Categories

- Full-Wave (3D)
 - Advantage:
 - They will simulate complex three-dimensional geometries, and they will predict frequency-dependent losses, internal inductance, dispersion, and most other electromagnetic phenomena, including radiation.

• Disadvantages:

- They are very difficult to use, and simulations typically take hours or days rather than seconds.
- Additionally, the output is often in the form of S
 parameters, which are not very useful for interconnect
 simulations for digital applications.

- Categories
 - Near-End Crosstalk (Backward Crosstalk)
 - The near-end current could be expressed as the summation of the inductance-induced and capacitance-induced currents

$$I_{\text{near}} = I(L_m) + I_{\text{near}}(C_m)$$

- Far-End Crosstalk (Forward Crosstalk)
 - The far-end current could be expressed as the difference of the inductance-induced and capacitance-induced currents

$$I_{\text{far}} = I_{\text{far}}(C_m) - I(L_m)$$

$$\xrightarrow{\text{Driver Current}}$$

$$\xrightarrow{\text{Driver Current}}$$

$$\xrightarrow{\text{Mutual Capacitance (Cm or C_1)}}$$

Line 1 (driver)

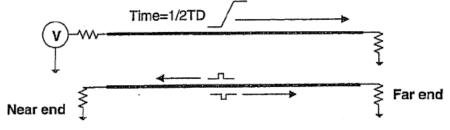
Line 2 (victim)

 $I_{near}\left(Cm\right)\ I_{far}(Cm)$

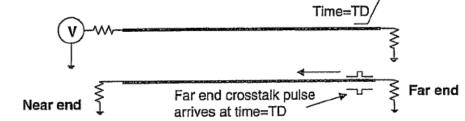
I(Lm)

- Graphical Representation
 - Near-End and Far-End Crosstalk

Signal propagated to the middle of the line



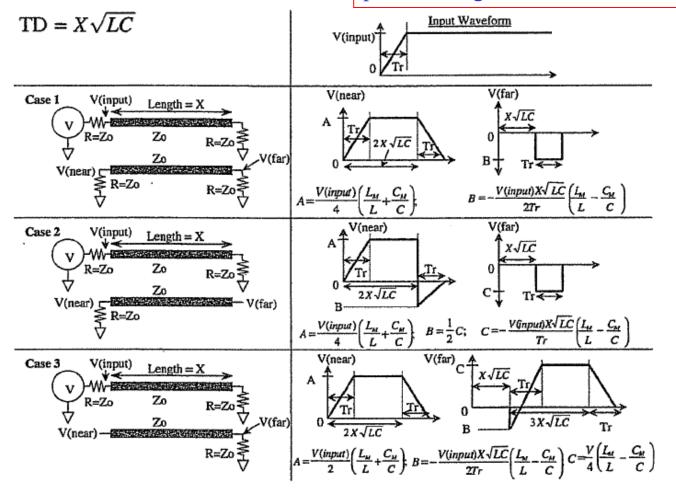
Signal propagated to the end of the line



- The near-end crosstalk will begin at time t=0 and have a duration of 2TD, or twice the electrical length of the line.
- Furthermore, the far-end crosstalk will occur at time *t*=TD and have a duration approximately equal to the signal rise or fall time.
- The magnitude and shape of the crosstalk noise depend heavily on the amount of coupling and the termination.

- Matched Terminations
 - When $T_r < 2TD$

where X is the line length and L and C are the self-inductance and capacitance of the transmission line per unit length.



Matched Terminations

- When T_r <2TD (Conti)
 - The near-end magnitude is independent of length for the long-line case, while the far end always depends on rise time and length.
- When $T_r > 2TD$
 - The near-end crosstalk will fail to achieve its maximum amplitude. To calculate the correct crosstalk voltages, simply multiply the near-end crosstalk by $2TD/T_r$.
 - The far-end crosstalk equations do not need to be adjusted.

- Mismatched Terminations
 - Only Victim Line Mismatched
 - Assume that the termination *R* in the victim line is not equal to the characteristic impedance of the victim transmission line, in this case the near- and far-end reflections must be added to the respective crosstalk voltages.

$$V_x = V_{\text{crosstalk}} \left(1 + \frac{R - Z_o}{R + Z_o} \right)$$

• where V_x is the crosstalk at the near or far end of the victim line adjusted for a nonperfect termination, R the impedance of the termination, Z_0 the characteristic impedance of the transmission line, and $V_{\text{crosstalk}}$ the value of perfect match.

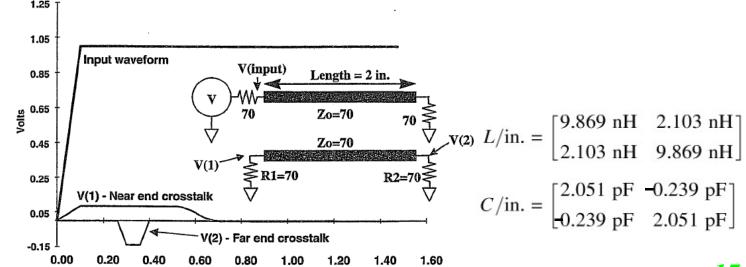
Conclusion

- For the Near-End Noise
 - If the rise or fall time is short compared to the delay of the line, the near-end crosstalk noise is independent of the rise time.
 - If the rise or fall time is long compared to the delay of the line, the near-end crosstalk noise is dependent on the rise time.
- For the Far-End Noise
 - The-far end crosstalk is always dependent on the rise or fall time.

- Examples
 - Example 3.2 Matched Terminations

Time, ns

• Assume $Z_0 \approx 70 \ \Omega$, the termination resistors = 70 Ω , $V(\text{input}) = 1.0 \ \text{V}$, $T_r = 100 \ \text{ps}$, and $X = 2 \ \text{in}$. Determine the near- and far-end crosstalk magnitudes assuming the following capacitance and inductance matrices:



- Examples
 - Example 3.2 Matched Terminations (Conti)
 - Using the equations described in case 1, we obtain
 - For the near-end crosstalk:

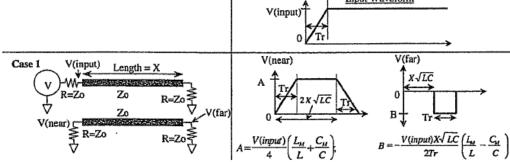
$$V(1) = \frac{V(input)}{4} \left[\frac{L_M}{L} + \frac{C_M}{C} \right] = \frac{1}{4} \left(\frac{2.103 \text{ nH}}{9.869 \text{ nH}} + \frac{0.239 \text{ pF}}{2.051 \text{ pF}} \right) = 0.082 \text{ V}$$

– For the far-end crosstalk:

$$V(2) = -\frac{V(input)X\sqrt{LC}}{2T_r} \left[\frac{L_M}{L} - \frac{C_M}{C} \right]$$

$$= \frac{1[2\sqrt{(9.869 \text{ nH})(2.051 \text{ pF})}]}{2(100 \text{ ps})} \left(\frac{2.103 \text{ nH}}{9.869 \text{ nH}} - \frac{0.239 \text{ pF}}{2.051 \text{ pF}} \right) = -0.137 \text{ V}$$

$$V(input) \uparrow \sqrt{\frac{Input Waveform}{V(input)}}$$



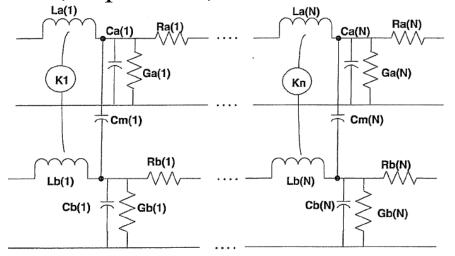
Examples

- Example 3.3 Mismatched Victim Terminations
 - If $R_1 = 45$ and $R_2 = 100 \Omega$, what are the respective near- and far-end crosstalk voltages?
 - Solution:

$$\begin{split} Z_o &= \sqrt{\frac{L_{11}}{C_{11}}} = \sqrt{\frac{9.869 \text{ nH}}{2.051 \text{ pF}}} = 69.4 \text{ }\Omega \\ V(1) &= V_{\text{crosstalk}} \left(1 + \frac{R - Z_o}{R + Z_o}\right) = 0.082 \left(1 + \frac{45 - 69.4}{45 + 69.4}\right) = 0.0645 \text{ V} \\ V(2) &= V_{\text{crosstalk}} \left(1 + \frac{R - Z_o}{R + Z_o}\right) = -0.137 \left(1 + \frac{100 - 69.4}{100 + 69.4}\right) = -0.162 \text{ V} \end{split}$$

Note: Near-end noise is modified by the reflection coefficient at the near end and far-end noise is modified by the reflection coefficient at the far end.

- Equivalent Circuit Model
 - A Pair of Coupled Lines
 - An *N*-segment equivalent circuit model of a pair of coupled lines as modeled in SPICE is depicted below, where *N* is the number of sections required such that the model will behave as a continuous transmission line and not as a series of lumped inductors, capacitors, and resistors.



- Equivalent Circuit Model
 - A Pair of Coupled Lines
 - The mutual inductance could be modeled as a coupling factor *K*:

$$K = \frac{L_{12}}{\sqrt{L_{11}L_{22}}}$$

- where L_{12} is the mutual inductance between lines 1 and 2, and L_{11} and L_{22} are the self-inductances of lines 1 and 2, respectively.
- Example 3.4 Creating a Coupled Line Model
 - Assume that a pair of coupled transmission lines is 5 in. long and a digital signal with a rise time of 100 ps is to be simulated. Capacitance matrix (per unit inch) = $\begin{bmatrix} 2 & pF & -0.1 & pF \\ 0.1 & pF & 2 & pF \end{bmatrix}$

- Equivalent Circuit Model
 - Example 3.4 Creating a Coupled Line Model
 - Calculate the characteristic impedance, the total propagation delay, the inductive coupling factor, the number of required segments, the maximum delay per segment, and the maximum L, R, C, G, C_m , and K values for one segment.
 - Solution:
 - Characteristic impedance: $Z_o = \sqrt{\frac{L_{11}}{C_{11}}} = \sqrt{\frac{9 \text{ nH}}{2 \text{ pF}}} = 67.09$
 - Total propagation delay:

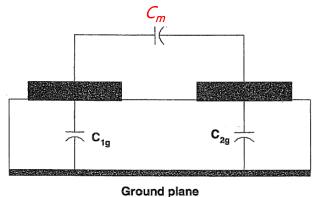
TD =
$$\sqrt{L_{11}C_{11}} = \sqrt{(9 \text{ nH})(2 \text{ pF})} = 134 \text{ ps/in.} \rightarrow (5 \text{ in}) = 670 \text{ ps}$$

• Inductive coupling factor: $K = \frac{L_{12}}{\sqrt{L_{11}L_{22}}} = \frac{0.7 \text{ nH}}{9 \text{ nH}} = 0.078$

- Equivalent Circuit Model
 - Example 3.4 Creating a Coupled Line Model
 - Minimum number of segments:

$$N = \text{segments} = 10 \frac{X}{vT_r} = 10 \frac{(5 \text{ in.})(134 \text{ ps/in.})}{100 \text{ ps}} = 67$$

• To calculate the inductance and capacitance per segment, the L, C, and C_m values must be multiplied by 5/67 (in./segment). Subsequently, L(N) = 0.67 nH, $C_{1g}(N) = C_{11}(N) - C_m(N) = 0.1425$ pF, and $C_m(N) = 0.0075$ pF.

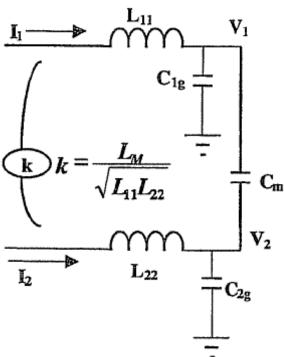


- Effect of Switching Patterns on TX Line Performance
 - Odd Mode

• Assume that $L_{11} = L_{22} = L_0$. Applying Kirchhoff's voltage law produces

$$V_1 = L_0 \frac{dI_1}{dt} + L_m \frac{dI_2}{dt}$$

$$V_2 = L_0 \frac{dI_2}{dt} + L_m \frac{dI_1}{dt}$$



- Effect of Switching Patterns on TX Line Performance
 - Odd Mode
 - Let $I_2 = -I_1$ and $V_2 = -V_1$, the equations become

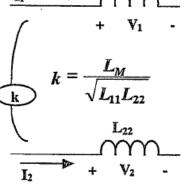
$$V_1 = L_0 \frac{dI_1}{dt} + L_m \frac{d(-I_1)}{dt} = (L_0 - L_m) \frac{dI_1}{dt}$$

$$V_2 = L_0 \frac{dI_2}{dt} + L_m \frac{d(-I_2)}{dt} = (L_0 - L_m) \frac{dI_2}{dt}$$

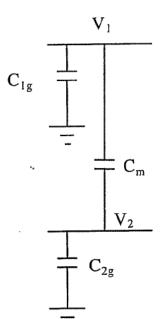
• Therefore, the equivalent inductance seen by line 1 propagating in odd mode is

$$L_{\rm odd} = L_{11} - L_m = L_{11} - L_{12}$$

The odd mode inductance is reduced.



- Effect of Switching Patterns on TX Line Performance
 - Odd Mode



• Applying Kirchhoff's current law at nodes V_1 and V_2 yields (assume that $C_{1g} = C_{2g} = C_0$)

$$I_1 = C_0 \frac{dV_1}{dt} + C_m \frac{d(V_1 - V_2)}{dt} = (C_0 + C_m) \frac{dV_1}{dt} - C_m \frac{dV_2}{dt}$$

$$I_2 = C_0 \frac{dV_2}{dt} + C_m \frac{d(V_2 - V_1)}{dt} = (C_0 + C_m) \frac{dV_2}{dt} - C_m \frac{dV_1}{dt}$$

• Let $I_2 = -I_1$ and $V_2 = -V_1$ for odd-mode propagation yields

$$I_1 = C_0 \frac{dV_1}{dt} + C_m \frac{d(V_1 - (-V_1))}{dt} = (C_{1g} + 2C_m) \frac{dV_1}{dt}$$

$$I_2 = C_0 \frac{dV_2}{dt} + C_m \frac{d(V_2 - (-V_2))}{dt} = (C_{2g} + 2C_m) \frac{dV_2}{dt}$$

• Therefore, the equivalent capacitance seen by trace

1 propagating in odd mode is

$$C_{\text{odd}} = C_{1g} + 2C_m = C_{11} + C_m$$

The odd mode capacitance is increased.

- Effect of Switching Patterns on TX Line Performance
 - Odd Mode
 - Subsequently, the equivalent impedance and delay for a coupled pair of transmission lines propagating in an odd-mode pattern are

$$Z_{\text{odd}} = \sqrt{\frac{L_{\text{odd}}}{C_{\text{odd}}}} = \sqrt{\frac{L_{11} - L_{12}}{C_{11} + C_{m}}}$$

$$TD_{\text{odd}} = \sqrt{L_{\text{odd}}C_{\text{odd}}} = \sqrt{(L_{11} - L_{12})(C_{11} + C_{m})}$$

• You could see that the odd mode characteristic impedance is reduced but the time delay is not obvious.

- Effect of Switching Patterns on TX Line Performance
 - Even Mode
 - For even-mode propagation, $I_1 = I_2$ and $V_1 = V_2$. Thus, the coupled line equations become

$$V_{1} = L_{0} \frac{dI_{1}}{dt} + L_{m} \frac{dI_{2}}{dt}$$

$$V_{1} = L_{0} \frac{dI_{1}}{dt} + L_{m} \frac{d(I_{1})}{dt} = (L_{0} + L_{m}) \frac{dI_{1}}{dt}$$

$$V_{2} = L_{0} \frac{dI_{2}}{dt} + L_{m} \frac{dI_{1}}{dt}$$

$$V_{2} = L_{0} \frac{dI_{2}}{dt} + L_{m} \frac{d(I_{2})}{dt} = (L_{0} + L_{m}) \frac{dI_{2}}{dt}$$

• Therefore, the equivalent inductance seen by line 1 propagating in even mode is

$$L_{\text{even}} = L_{11} + L_m$$
 The even mode inductance is increased.

• Similarly. We have
$$I_{1} = C_{0} \frac{dV_{1}}{dt} + C_{m} \frac{d(V_{1} - V_{2})}{dt}$$

$$I_{2} = C_{0} \frac{dV_{2}}{dt} + C_{m} \frac{d(V_{2} - V_{1})}{dt}$$

$$I_{3} = C_{0} \frac{dV_{2}}{dt} + C_{m} \frac{d(V_{2} - V_{1})}{dt}$$

$$I_{4} = C_{0} \frac{dV_{2}}{dt} + C_{m} \frac{d(V_{2} - V_{2})}{dt} = (C_{0}) \frac{dV_{2}}{dt}$$

- Effect of Switching Patterns on TX Line Performance
 - Even Mode
 - Therefore, the equivalent capacitance seen by trace 1 propagating in even mode is

$$C_{\text{even}} = C_0 = C_{11} - C_m$$
 The even mode capacitance is reduced.

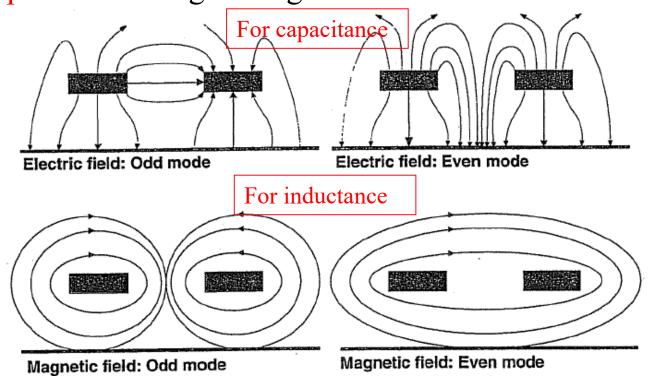
• Subsequently, the even-mode characteristic impedance and time delay are

$$Z_{\text{even}} = \sqrt{\frac{L_{\text{even}}}{C_{\text{even}}}} = \sqrt{\frac{L_{11} + L_{12}}{C_{11} - C_m}}$$

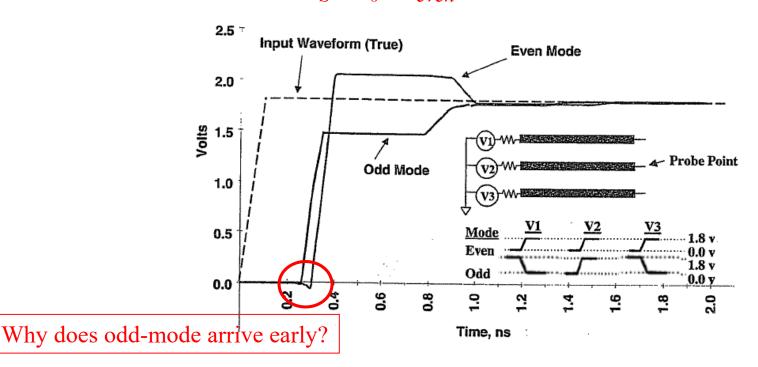
$$\text{TD}_{\text{even}} = \sqrt{L_{\text{even}}C_{\text{even}}} = \sqrt{(L_{11} + L_{12})(C_{11} - C_m)}$$

• You could see that the even mode impedance is increased but the time delay is not obvious.

- Effect of Switching Patterns on TX Line Performance
 - Field Patterns of Odd and Even Modes
 - Please think about the variations of inductance and capacitance using this figure.



- Effect of Switching Patterns on TX Line Performance
 - Effects of Switching Patterns
 - Odd Mode: $Z_S = Z_0 > Z_{odd}$, underdriven
 - Even Mode: $Z_S = Z_0 < Z_{even}$, overdriven



- Effect of Switching Patterns on TX Line Performance
 - Conclusions
 - Odd-mode impedance will always be lower than the single-line case.
 - Even-mode impedance will always be higher than the single-line case.
 - The signal pattern influence on the time delay for odd- and even-mode are not obvious.
 - Crosstalk will induce velocity variations in a microstrip.
 - However, crosstalk will not induce velocity variations in a stripline.

- Simulating Traces in a Multiconductor System Using a Single-Line Equivalent Circuit
 - All Signals in Phase
 - Let the target be line 2, the equivalent impedance and time delay per unit length seen by line 2 can be calculated as

$$Z_{2,\text{eff}} = \sqrt{\frac{L_{22} + L_{12} + L_{23}}{C_{22} - C_{12} - C_{23}}}$$

$$TD_{2,\text{eff}} = \sqrt{(L_{22} + L_{12} + L_{23})(C_{22} - C_{12} - C_{23})}$$

- Simulating Traces in a Multiconductor System Using a Single-Line Equivalent Circuit
 - One Signal Out of Phase with Other Signals
 - For equivalent capacitance of line 2:
- Even-mode capacitance of conductor 2 with $1=C_{22}-C_{12}$ Odd-mode capacitance of conductor 2 with $3=C_{22}+C_{23}$
 - Equivalent capacitance of conductor $2=C_{22}-C_{12}+C_{23}$
 - For equivalent inductance of line 2:
 - Even-mode inductance of conductor 2 with $1=L_{22}+L_{12}$
 - Odd-mode inductance of conductor 2 with $3=L_{22}-L_{23}$
 - Equivalent inductance of conductor $2=L_{22}+L_{12}-L_{23}$
 - The equivalent impedance and time delay are

$$Z_{2,\text{eff}} = \sqrt{\frac{L_{22} + L_{12} - L_{23}}{C_{22} - C_{12} + C_{23}}} \quad \text{TD}_{2,\text{eff}} = \sqrt{(L_{22} + L_{12} - L_{23})(C_{22} - C_{12} + C_{23})} \quad 34$$

- Simulating Traces in a Multiconductor System Using a Single-Line Equivalent Circuit
 - Conclusion
 - When estimating the effect of crosstalk in a system, the nearest neighbors have the greatest effect. The effects of the other lines fall off exponentially.
 - The SLEM method should be used early in the design stage to quickly get a handle on the effect of crosstalk. Fully coupled simulations should always be performed on the final design.
 - Common mode (all bits in phase) and differential mode (target bit out of phase) will produce the worst-case impedance and velocity variations.
 - The accuracy of a three-line SLEM model falls off when the edge-to-edge spacing/height (above the ground plane) ratio is less than 1.

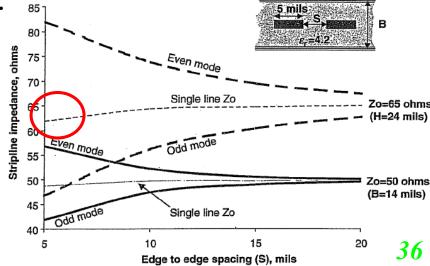
Crosstalk Trends

- Different Perspectives
 - From Impedance

Better electromagnetic field confining

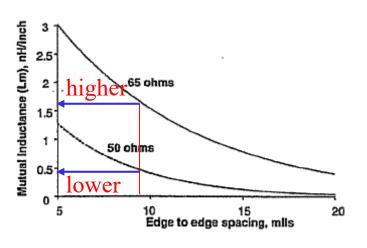
by widening the trace width or using a thinner dielectric. Thus, Lower-impedance traces will tend to exhibit less crosstalk-induced impedance variation than will high-impedance traces for a given dielectric constant.

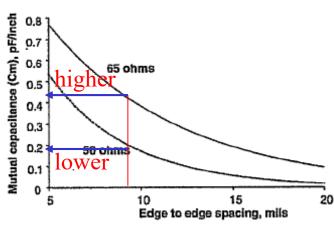
For a single line Z_0 , it will start to increase the self-capacitance of the single line while the edge-to-edge spacing is small, thus, reducing the characteristic impedance, although the adjacent line is not excited.



Crosstalk Trends

- Different Perspectives
 - From Mutual Inductance and Capacitance
 - Note that the mutual parasitics drop off exponentially with spacing.
 - The mutual inductance and capacitance for lower-impedance lines are smaller than those for higher-impedance lines.





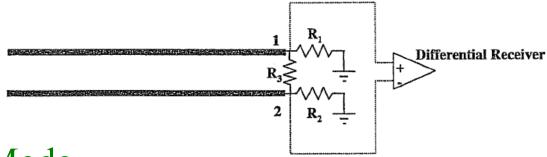
Crosstalk Trends

Conclusion

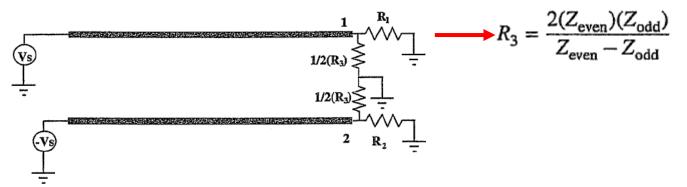
- Points to Remember
 - For a given dielectric constant, low-impedance line will produce less impedance variations from crosstalk.
 - The impedance of a single line on a board is influenced by the proximity of other traces even when they are not being actively driven.
 - Mutual parasitics fall off exponentially with traceto-trace spacing.

Termination of Odd- and Even-Mode Transmission Line Pairs

- Pi-Termination Network
 - Even Mode
 - Since $V_1 = V_2 = V_e$, we obtain $R_1 = R_2 = Z_{even}$

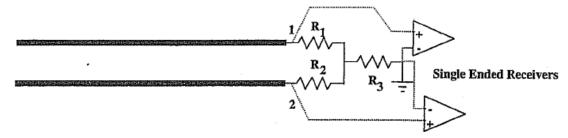


- Odd Mode
 - Since $V_1 = V_2 = V_0$, we obtain $Z_{\text{odd}} = (1/2R_3)//R_1$



Termination of Odd- and Even-Mode Transmission Line Pairs

- T-Termination Network
 - Odd Mode
 - Since $V_1 = V_2 = V_0$, we obtain $R_1 = R_2 = Z_{\text{odd}}$



- Even Mode
 - Since $V_1 = V_2 = V_e$, we obtain $Z_{even} = R_1 + 2R_3$

$$R_3 = \frac{1}{2}(Z_{\text{even}} - Z_{\text{odd}})$$



Minimization of Crosstalk

Rule of Thumb

- 1. Widen the spacing S between the lines as much as routing restrictions will allow.
- 2. Design the transmission line so that the conductor is as close to the ground plane as possible (i.e., minimize *H*) while achieving the target impedance of the design. This will couple the transmission line tightly to the ground plane and less to adjacent signals.
- 3. Use differential routing techniques for critical nets, such as the system clock if system design allows.

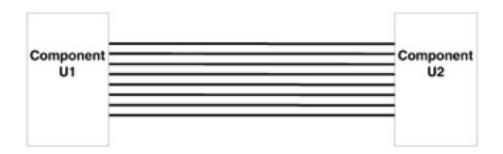
Minimization of Crosstalk

• Rule of Thumb (Conti)

- 4. If there is significant coupling between signals on different layers (such as layers M3 and M4), route them orthogonal to each other.
- 5. If possible, route the signals on a stripline layer or as an embedded microstrip to eliminate velocity variations.
- 6. Minimize parallel run lengths between signals. Route with short parallel sections and minimize long coupled sections between nets.
- 7. Place the components on the board to minimize congestion of traces.
- 8. Use slower edge rates. This, however, should be done with extreme caution. There are several negative consequences associated with using slow edge rates.

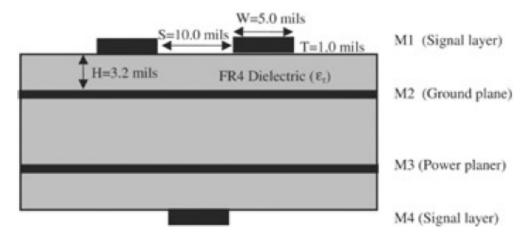
Problem

• Assume that two components, U_1 and U_2 , need to communicate with each other via an 8-bitwide high-speed digital bus.



• The components are mounted on a standard four-layer motherboard with the stackup shown below. The driving buffers on component U_1 have an impedance of 30 Ω and a swing of 0 to 2 V.

Problem



- The traces on the printed circuit board (PCB) are required to be 5 in. long with center-to-center spacing of 15 mils and impedance 50 Ω (ignoring crosstalk).
- The relative dielectric constant of the board (ε_r) is 4.0.

Problem

- The transmission line parasitics are
 - mutual inductance = 0.54 nH/in.
 - mutual capacitance = 0.079 pF/in.
 - self-inductance = 7.13 nH/in. (from the Chapter 2, additional example)
 - self-capacitance = 2.85 pF/in. (from the Chapter 2, additional example)

Goals

- 1. Determine the maximum impedance variation.
- 2. Determine the maximum velocity difference.
- 3. Assuming that the input buffers at component U_2 will switch at 1.0 V, determine if the buffer will false trigger due to crosstalk effects.

- Determining the Maximum Crosstalk-Induced Impedance and Velocity Swing
 - The patterns that produce the worst-case crosstalk effects will always be either common mode or differential mode.
 - Common-Mode Propagation

Ground plan

- For calculation of equivalent capacitance:
 - Even-mode capacitance of conductors 2 and $1 = C_{22}$ C_{12}
 - Even-mode capacitance of conductors 2 and 3 = C_{22} C_{23}
 - Equivalent capacitance of conductor 2 = C_{22} C_{12} C_{23}
- For calculation of equivalent inductance:
 - Even-mode inductance of conductors 2 and $1 = L_{22} + L_{12}$
 - Even-mode inductance of conductors 2 and $3 = L_{22} + L_{23}$
 - Equivalent inductance of conductor $2 = L_{22} + L_{12} + L_{23}$

- Determining the Maximum Crosstalk-Induced Impedance and Velocity Swing
 - Common-Mode Propagation (Conti)
 - Therefore, the characteristic impedance and time delay are

$$\begin{split} Z_{2,\text{common}} &= \sqrt{\frac{L_{22} + L_{12} + L_{23}}{C_{22} - C_{12} - C_{23}}} \\ &= \sqrt{\frac{7.13 \text{ nH} + 0.54 \text{ nH} + 0.54 \text{ nH}}{2.85 \text{ pF} - 0.079 \text{ pF}}} = 55.26 \ \Omega \end{split}$$

$$TD_{2,common}$$

=
$$\sqrt{(L_{22} + L_{12} + L_{23})(C_{22} - C_{12} - C_{23})}$$

= $\sqrt{(7.13 \text{ nH} + 0.54 \text{ nH} + 0.54 \text{ nH})(2.85 \text{ pF} - 0.079 \text{ pF} - 0.079 \text{ pF})}$
= 148.6 pF/in.

- Determining the Maximum Crosstalk-Induced Impedance and Velocity Swing,
 - Differential-Mode Propagation



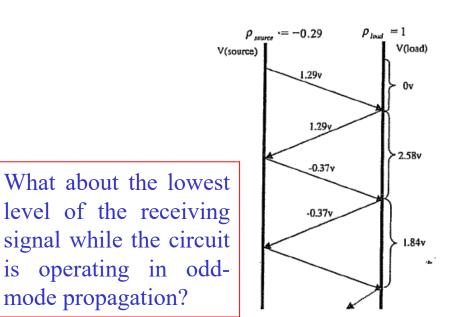
- For calculation of equivalent capacitance:
 - Odd-mode capacitance of conductors 2 and $1 = C_{22} + C_{12}$
 - Odd-mode capacitance of conductors 2 and $3 = C_{22} + C_{23}$
 - Equivalent capacitance of conductor $2 = C_{22} + C_{12} + C_{23}$
- For calculation of equivalent inductance:
 - Odd-mode inductance of conductors 2 and $1 = L_{22} L_{12}$
 - Odd-mode inductance of conductors 2 and 3 = L_{22} L_{23}
 - Equivalent inductance of conductor 2 = L_{22} L_{12} L_{23}

- Determining the Maximum Crosstalk-Induced Impedance and Velocity Swing
 - Differential-Mode Propagation (Conti)
 - Therefore, the characteristic impedance and time delay are

$$\begin{split} Z_{2,\text{differential}} &= \sqrt{\frac{L_{22} - L_{12} - L_{23}}{C_{22} + C_{12} + C_{23}}} \\ &= \sqrt{\frac{7.13 \text{ nH} - 0.54 \text{ nH} - 0.54 \text{ nH}}{2.85 \text{ pF} + 0.079 \text{ pF}} + 0.079 \text{ pF}}} = 44.8 \ \Omega \\ \text{TD}_{2,\text{differential}} \\ &= \sqrt{(L_{22} - L_{12} - L_{23})(C_{22} + C_{12} + C_{23})} \\ &= \sqrt{(7.13 \text{ nH} - 0.54 \text{ nH} - 0.54 \text{ nH})(2.85 \text{ pF} + 0.079 \text{ pF})} \\ &= 135 \text{ ps/in.} \end{split}$$

• The velocity and impedance variations due to crosstalk are as follows: $44.8 \Omega < Z_o < 55.26 \Omega$

- Determining if Crosstalk Will Induce False Triggers
 - Since the most ringing will occur when the driver impedance is low and the transmission line impedance is high (overdriven), *common mode propagation* is chosen.



$$V_{initial} = Vs \frac{Zo}{Rs + Zo} = (2) \left(\frac{55}{30 + 55}\right) = 1.29$$

$$\rho_{source} = \frac{Rs - Zo}{Rs + Zo} = \frac{30 - 55}{30 + 55} = -0.29$$

$$\rho_{load} = \frac{Zl - Zo}{Zl + Zo} = \frac{\infty - 55}{\infty + 55} = 1$$
No false triggers since the voltage is greater than $V_{TH} = 1V$.

Worst case waveform at U2

